

October 1995

6A, 1200V Ultrafast Dual Diode

Features

•	Ultrafast with Soft Recovery <70ns
•	Operating Temperature +175°C
•	Reverse Voltage

- · Avalanche Energy Rated
- Planar Construction

Applications

- Switching Power Supplies
- · Power Switching Circuits
- General Purpose

Description

The RURP6120CC is an ultrafast dual diode with soft recovery characteristics (t_{RR} < 70ns). It has low forward voltage drop and is silicon nitride passivated ion-implanted epitaxial planar construction.

This device is intended for use as a freewheeling/clamping diode and rectifier in a variety of switching power supplies and other power switching applications. Its low stored charge and ultrafast soft recovery minimize ringing and electrical noise in many power switching circuits reducing power loss in the switching transistors.

PACKAGE AVAILABILITY

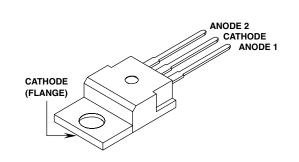
PART NUMBER	PACKAGE	BRAND
RURP6120CC	TO-220AB	RUR6120C

NOTE: When ordering, use the entire part number.

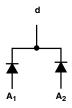
Formerly developmental type TA49039.

Package

JEDEC TO-220AB



Symbol



Absolute Maximum Ratings (per leg) $T_C = +25$ °C, Unless Otherwise Specified

	RURP6120CC	UNITS
Peak Repetitive Reverse Voltages	1200	V
Working Peak Reverse VoltageV _{RWM}	1200	V
DC Blocking Voltage	1200	V
Average Rectified Forward Current $I_{F(AV)}$ $T_C = +140^{\circ}C$	6	Α
Repetitive Peak Surge CurrentI _{FSM} Square Wave, 20kHz	12	Α
Nonrepetitive Peak Surge Current	60	Α
Maximum Power Dissipation	50	W
Avalanche Energy (See Figures 10 and 11)	10	mj
Operating and Storage Temperature	-65 to +175	°C

Specifications RURP6120CC

Electrical Characteristics (per leg) $T_C = +25^{\circ}C$, Unless Otherwise Specified

		RURP6120CC LIMITS			
SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNITS
V _F	I _F = 6A, T _C = +25°C	-	-	2.1	V
	I _F = 6A, T _C = +150°C	-	-	1.9	V
I _R	V _R = 1200V, T _C = +25°C	-	-	100	μА
	V _R = 1200V, T _C = +150°C	-	-	500	μА
t _{RR}	$I_F = 1A$, $dI_F/dt = 200A/\mu s$	-	-	70	ns
	$I_F = 6A$, $dI_F/dt = 200A/\mu s$	-	-	90	ns
t _A	$I_F = 6A$, $dI_F/dt = 200A/\mu s$	-	45	-	ns
t _B	$I_F = 6A$, $dI_F/dt = 200A/\mu s$	-	30	-	ns
Q _{RR}	$I_F = 6A$, $dI_F/dt = 200A/\mu s$	-	400	-	nC
CJ	V _R = 10V, I _F = 0A	-	22	-	pF
$R_{ heta JC}$		-	-	3	°C/W

DEFINITIONS

 V_F = Instantaneous forward voltage (pw = 300 μ s, D = 2%).

I_R = Instantaneous reverse current.

 t_{RR} = Reverse recovery time (See Figure 2), summation of $t_A + t_B$.

 t_A = Time to reach peak reverse current (See Figure 2).

t_B = Time from peak I_{RM} to projected zero crossing of I_{RM} based on a straight line from peak I_{RM} through 25% of I_{RM} (See Figure 2).

Q_{RR} = Reverse recovery charge.

 C_J = Junction Capacitance.

 $R_{\theta JC}$ = Thermal resistance junction to case.

 $\mathsf{E}_{\mathsf{AVL}}$ = Controlled Avalanche Energy (See Figures 10 and 11).

pw = pulse width.

D = duty cycle.

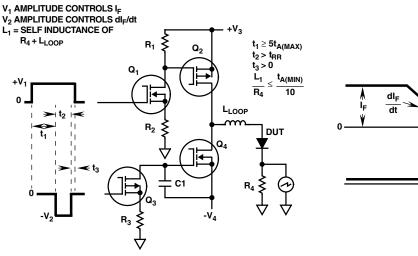


FIGURE 1. t_{RR} TEST CIRCUIT

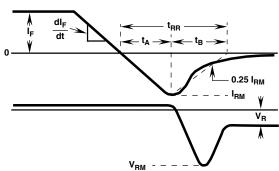
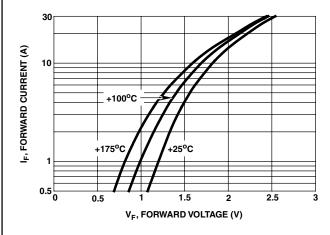


FIGURE 2. t_{RR} WAVEFORMS AND DEFINITIONS

Typical Performance Curves



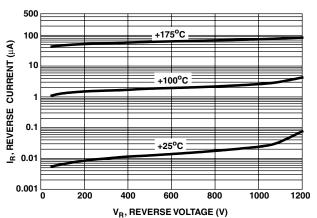
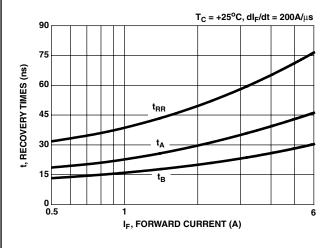


FIGURE 3. TYPICAL FORWARD CURRENT vs FORWARD VOLTAGE DROP

FIGURE 4. TYPICAL REVERSE CURRENT vs REVERSE VOLTAGE



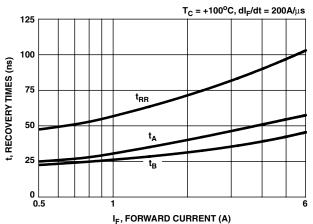
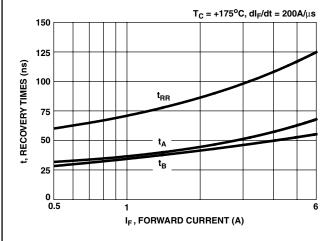


FIGURE 5. TYPICAL t_{RR} , t_{A} AND t_{B} CURVES vs FORWARD CURRENT AT +25°C

FIGURE 6. TYPICAL t_{RR} , t_{A} AND t_{B} CURVES vs FORWARD CURRENT AT +100°C

Typical Performance Curves (Continued)



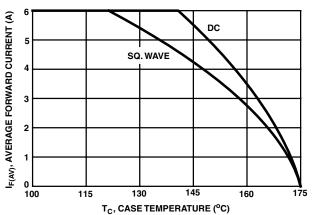


FIGURE 7. TYPICAL t_{RR} , t_{A} AND t_{B} CURVES vs FORWARD CURRENT AT +175°C

FIGURE 8. CURRENT DERATING CURVE

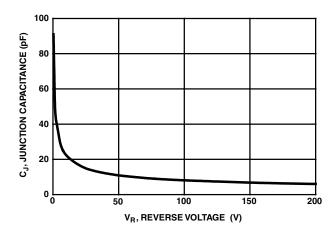
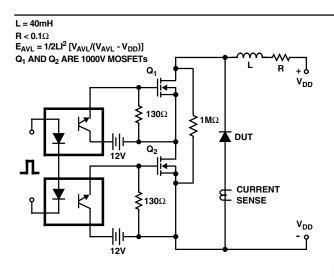


FIGURE 9. TYPICAL JUNCTION CAPACITANCE vs REVERSE VOLTAGE



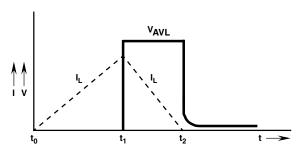
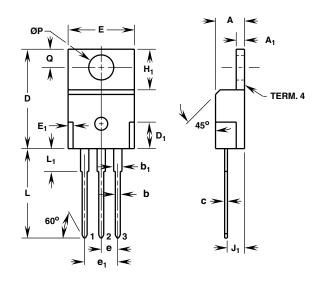


FIGURE 10. AVALANCHE ENERGY TEST CIRCUIT

FIGURE 11. AVALANCHE CURRENT AND VOLTAGE WAVE-FORMS

Plastic Packages



LEAD 1. ANODE 1

LEAD 2. CATHODE

LEAD 3. ANODE 2

TERM. 4. CATHODE

TO-220AB 3 LEAD JEDEC TO-220AB PLASTIC PACKAGE

	INCHES		MILLIMETERS		
SYMBOL	MIN	MAX	MIN	MAX	NOTES
Α	0.170	0.180	4.32	4.57	-
A ₁	0.048	0.052	1.22	1.32	-
b	0.030	0.034	0.77	0.86	3, 4
b ₁	0.045	0.055	1.15	1.39	2, 3
С	0.014	0.019	0.36	0.48	2, 3, 4
D	0.590	0.610	14.99	15.49	-
D ₁	-	0.160	-	4.06	-
E	0.395	0.410	10.04	10.41	-
E ₁	-	0.030	-	0.76	-
е	0.100	TYP	2.54	TYP	5
e ₁	0.200 BSC		5.08	BSC	5
H ₁	0.235	0.255	5.97	6.47	-
J ₁	0.100	0.110	2.54	2.79	6
L	0.530	0.550	13.47	13.97	-
L ₁	0.130	0.150	3.31	3.81	2
ØP	0.149	0.153	3.79	3.88	-
Q	0.102	0.112	2.60	2.84	-

NOTES:

- These dimensions are within allowable dimensions of Rev. J of JEDEC TO-220AB outline dated 3-24-87.
- 2. Lead dimension and finish uncontrolled in L_1 .
- 3. Lead dimension (without solder).
- 4. Add typically 0.002 inches (0.05mm) for solder coating.
- 5. Position of lead to be measured 0.250 inches (6.35mm) from bottom of dimension D.
- 6. Position of lead to be measured 0.100 inches (2.54mm) from bottom of dimension D.
- 7. Controlling dimension: Inch.
- 8. Revision 1 dated 1-93.

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